Integrated
Advanced Microwave Sounding Unit-A (AMSU-A)
METSAT A1 Signal Processor Engineering Test Report
(P/N: 1331670-2, S/N: F01)

Contract No. NAS 5-32314 CDRL 207

Submitted to:

National Aeronautics and Space Administration Goddard Space Flight Center Grennbelt, Maryland 20771

Submitted by:

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## 1.0 Introduction

This report presents a description of the tests performed, and the test data, for the A1 METSAT Signal Processor Assembly PN: 1331670-2, S/N F01. The assembly was tested in accordance with AE-26754, "METSAT Signal Processor Scan Drive Test and Integration Procedure".

The tests were conducted at room temperature in the AMSU-A test area of building 57. The tests fall into six categories: 1) Continuity, 2) Power Distribution, 3) Digital Processor, 4) Analog Processor, 5) Scan Drive, and 6) Supply Current.

# 2.0 Objective

The objective is to demonstrate functionality of the signal processor prior to instrument integration.

# 3.0 Test Data

All test data is presented on the enclosed copies of the test data sheets (TDSs) numbered A-2 through A-14. Redlines to the data sheets were necessary and were accomplished in accordance with program directive No. 91. Each change was approved by Quality and the test engineer. Changes were made for the following reasons: 1) Notes were added to verify the test equipment and/or test setup was correct, 2) Command instructions were clarified to remove any ambiguity in the instructions, and 3) Added and/or removed steps to improve the test flow.

## 4.0 TESTS

# 4.1 Continuity

A complete continuity test of the backplane wiring is performed at the facility where the wirewrapping of the backplane is done. The continuity tests performed here involve 1) the I/O interface card slots, J301 and J326, 2) the Aerojet added Pre-amp/detector signal cable and connector, 3) the Aerojet added Pre-amp/detector power cable and connector, and 4) chassis return connections. The tests are manual resistance measurements tests. Test data is presented on TDS 1.

### 4.2 Power Distribution

In these tests supply voltages are input to the signal processor from the Test Relay Unit (TRU) as in normal testing. No CCAs are installed in the signal processor for the tests. The test verifies that the four supply voltages are present on the proper pins of all backplane connectors. The test setup block diagram is shown in Figure 1, and test data is presented on TDS 2.

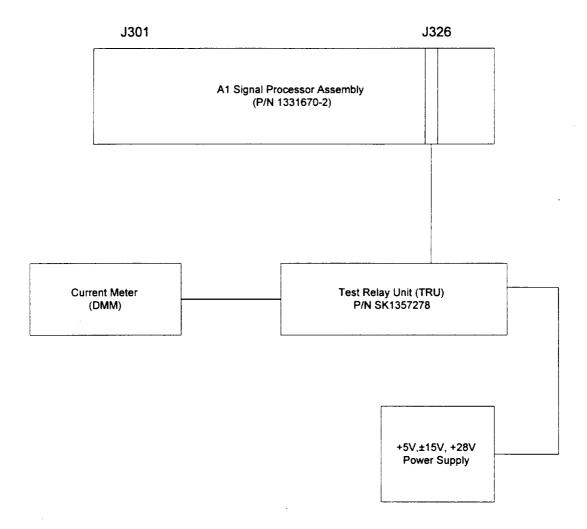


Figure 1. A1 Signal Processor Test Setup

# 4.3 Digital Processor

Beginning with this test, CCAs are installed into the card cage as required to perform the test, and then remain installed. At the conclusion of all tests, a complete set of CCAs has been installed. The complete test setup block diagram which is required for performing any of the tests is shown in Figure 2.

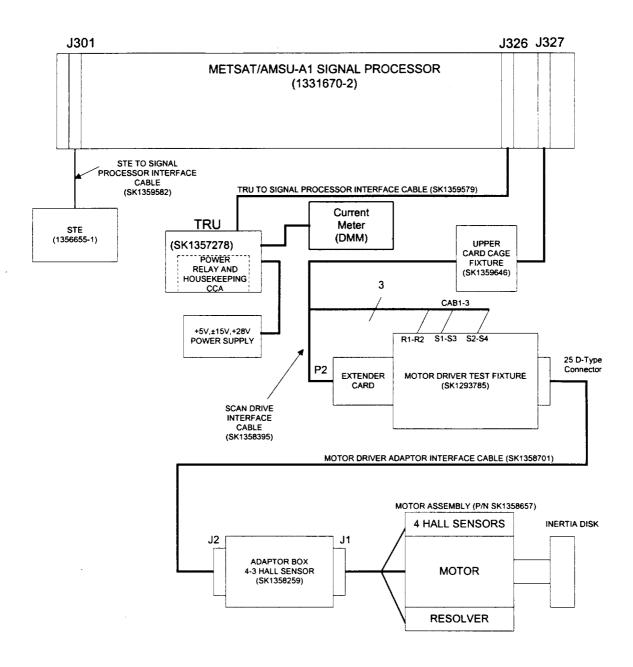


Figure 2 Scan Drive Test Set-Up

## 4.3.1 Memory

In this test, the digital test set is used in place of the CPU CCA to read and verify data of the test PROMs on the "GOLD" Memory CCA. Test data is presented on TDS 3.

#### 4.3.2 CPU

The CPU test requires that the CPU Auxiliary test CCA be installed in place of the Memory CCA. In this test, the RAM and various instructions performed by the CPU are tested. In addition, the waveform of the clock signal to the DC-DC converter is measured at the CLOCK jack on the TRU. Test data is presented on TDS 3.

#### 4.3.3 Scan Control Interface

In this test, input and output ports 0 through 3 are tested. In addition, the disable feature of the input ports is checked out. Test data is presented on TDS 3.

### 4.3.4 Timing and Control

In this test, the proper time intervals of I/H, DUMP, INTCMPL, TSCMPL, STOP, and ANTENNA STROBE are verified. In addition to the above tests, the test set also checks the input ports 16 and 17, output port #13 (4 MSBs), output port 14, input port #15 (DAC BSY signal), and output port #13 (4 LSBs). Test data is presented on TDS 3.

## 4.3.5 Spacecraft Interface

In this test, the STE is turned on and initialized. The STE is tested with a series of self-tests to verify the readiness of the STE to test flight hardware. After successfully passing the self-tests, the STE is used to simulate the spacecraft command signals and retrieve limited test data for the remaining signal processor tests. STE test data is presented on TDS 4.

### 4.3.6 Relay Control

This test verifies the operation of the module power command and the survival heater command. The presence of the +10 volt Interface power is verified. The PLO lock alarm signals, Scan 1 and 2 relay drive and position indicators, and PLO relay drive and relay position indicators are also verified. Test data is presented on TDS 4.

## 4.4 Analog Processor

# 4.4.1 Independence of Measurements

This test is performed using the Analog CCA Test Fixture, the Integrate and Dump Filter and the Analog Mux and A/D Converter CCAs. The test gives a measurement of the sample-to-sample crosstalk within a channel, which is dependent on the completeness of the dump of the integration capacitor. Test data is presented on TDS 5.

# 4.4.2 Integrate/dump filter, radiometric data multiplexing, and digitization tests

In this test, a 2 volt dc signal is input to each integrate and dump filter, and the channel output code from the A/D converter is measured. The integrator output waveform is also displayed on an oscilloscope for verification of timing. Test data is presented on TDS 6.

### 4.4.3 Temperature monitoring circuits

In this test a resistor of value approximating the room temperature resistance of the PRTs is connected at the input of each PRT readout circuit, and the output code from the A/D converter is measured. The reference voltage used in the PRT readout circuits is also measured. Test data is presented on TDS 7.

# 4.4.4 Analog telemetry

In this test each of the analog telemetry signals is measured at the ANALOG HSKP jack on the TRU. Test data is presented on TDS 8.

#### 4.5 Scan Drive

This test includes all CCAs involved in the scan drive function. The circuitry is programmed to provide one complete revolution of the drive motor as it steps through each of the thirty scene positions and the two calibration positions. The circuitry is programmed to park at the Warm Cal, Cold Cal, and the Nadir positions during the test sequence. The GSE test modes are also verified. To verify proper performance, the inertia disk on the motor shaft is visually observed through the one revolution and the various calibration positions. Test data is presented on TDS 9.

## 4.6 Supply Current

In this test, the total current drawn by the signal processor from each of the four supply voltages is measured with the signal processor fully populated with CCA's. Test data is presented on TDS 10.

### 5.0 TEST ANOMALIES

Two test anomalies occurred. The first anomaly occurred when the clock signal was to be measured at the clock jacks on the TRU. No clock signal was present. The test was stopped and a Test Anomaly Report (attached) was opened (TAR 003142). Troubleshooting and visual inspection revealed that a twisted pair clock line was missing from the backplane. The test was continued and the twisted pair clock line was added by the wirewrap supplier after test completion.

The second anomaly occurred during the signal processor power distribution test. Minus 15 volts was measured on the +10 volt output. The test was stopped and a Test Anomaly Report (attached) was opened (TAR 002330). Troubleshooting and visual inspection revealed a piece of bare wire wedged between two sockets on connector J326. This wire shorted the -15V output to the +10V output (not powered at the time). The wire short was removed and the test was continued and successfully passed.

# 6.0 TEST RESULTS

The METSAT/AMSU A1 SIGNAL PROCESSOR TEST was successfully completed and all test data is within specified limits.

# TEST DATA SHEET 1 A1 Continuity Tests (4.2.1)

From	То	Signal Name	Pass/Fail
J301-1	P511-3	CH3-IN	Pass
J301-10	P511-13	CH 8 - IN	Pass
J301-13	P511-15	CH 9 - IN	1255
J301-15	P511-17	CH 10 - IN	P255
J301-16	P511-19	CH 11 - IN	255
J301-19	P511-21	CH 12 - IN	1255
J301-21	P511-23	CH 13 - IN	Pass
J301-22	P511-25	CH 14 - IN	17255
J301-25	P511-1	CH 15 - IN	Pass
J301-3	P511-5	CH 4 - IN	Pass
J301-4	P511-7	CH 5 - IN	P255
J301-60	E1	CHASSIS GND	Pas 5
J301-7	P511-9	CH 6 - IN	P255
J301-9	P511-11	CH 7 - IN	P255
J301-90	E2	CHASSIS GND	P265
J304-43	P512-5	+15V(2)	17255
J304-45	P512-24	+15V(2)	Pass
J304-46	P512-9	15VRTN(2/3)	1255
J304-48	P512-29	15VRTN(2/3)	12=5
J304-49	P512-14	-15V(3)	P250
J304-51	P512-15	-15V(3)	P265
J305-68	P512-12	PRT35_HI (PRE AMP)	13255
J305-72	P512-11	PRT35_LO (PRE AMP)	1255
J326-76	E3	CHASSIS GND	17255

Assembly No. / 33/670-2	Shop Order No. 292504
Serial No. FO/	Pass Fail
Test Engineer Sund 3/4/98 (Signature (Date)	Quality Control (Signature) (Date)
Customer Representative (Flight hardware only)	Draw 3.31.98

# TEST DATA SHEET 2 Al Power Distribution (Paragraphs 4.2.2 & 4.2.3)

Power Su	pply Voltages:	7.	21/	<del></del>		5.7 ± 0.1V:	+,	15.751	/		
•	$+ 5.7 \pm 0.1 \text{V}$ : -15.7 $\pm 0.1 \text{V}$ :	+5,70	72 1	<del></del>	+1 ±2	$8.7 \pm 0.1 \text{V}$ :	+ 2	28,70V			
	·13.7 ± 0.1 v :		~	_		0.7 = 0.1					
Test Set-1	ıp Verified:	YE	is	NO_		_					
ļ		T	Γ				0/5			0:41/	5/5
Para. 4.2.3	Connector No.	+5 ±0.5 V	P/F	+15 ±0.3V	P/F	-15 ±0.3V	P/F	+28 ±0.56V	P/F	+9 ±1V	P/F
Step	INO.	20.0								*	''
No.										- 10	
7 14	J301									+8.69	P
21	J303			+15,05		-15.03	P				
81	J304			+15.05	P	-15.03	P				
A-3	J305			+15,05	P	-15,03	P				
54	J306			+15,05	12	-15,03					
£5	J307	+4,96	P	+15.05	12	-15,03	12				
25	J308			+15.05	12	-15.03	12				
85	J309			+15.05	<i>P</i>	-15.03	P				
85	J310			415.05	12	-15.03	P				
85	J311		(2	+15,05	12	-15,03				+8.68	در
85	J312 J313	+4,96	P							+8.68	P
85	J314	+4.97								10.00	
85	J315	+4.96	P								
85	J316	+4.96	P								
85	J317	+4.96	P								
85	J318	+4.96	13								
85	J319	+4.96	<i>1</i> 2	+15.05	12	-15.03	2	+27.97	P		
85	J320	+4.97	P	+15.05		-15,03					
-8-5	J321	+4.97	P	173.00							
85	J322	+4.97	P	+15.05	در	-15.03	P				
85	J323	+4.97	12	+15.05	$\overline{}$	-15.03					
55	J324	+4.97	12								
56.5	J325	+4.97	10	+15.05	70	-15.03	P				
76	J327	+4.28	P	+15.05	P	-15.03	٩	+27.96	10		
× nea	sured a	<del></del>	4 0,5 4	4,2,5,2	Tes	t	0	91504			
Assembly	No. <u>/ 33/6</u>	70-2			Sh	op Order No		72307			
Serial No	Serial No. Fol Pass Fail										
Test Engi	Test Engineer L Land 3/4/98 Quality Control & Shaper 3.8.98										
Test Eligi	Test Engineer Quality Control Quality Control (Signature) (Date)										
Customas	Representativ	e (Elight has	dware a	$VQ_{\text{tyles}}$	2,		3-31	.98			
Customer	Representativ	e (Lugui nar	nwate (	(Sign	ature)		(Da				
Ì											

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# TEST DATA SHEET 3 (Sheet 1 of 2) A1 Digital Processor (Paragraph 4.2.4)

Scan Co		5) <u>F08</u> A Serial No. (J318) <u>F</u> Serial No. (J315) <u>F0</u>			
4.2.4.1 Memory test	<b>s:</b>				
4.2.4.1/10 Circle Pass	or Fail to indicate	the result of the tests:		Pass Fail	
If "I	Fail", record the en	ror code and error descrip	tion.		
	Error Code:	None			
	Error Description	on: None	<del></del>		
• •		. •			
4.2.4.2 CPU tests:	• •				
4.2.4.2/10		Measurements	Limits	Pass/Fai	<u>1</u>
	V <sub>p</sub> -p	4.00V	3.30 - 4.94 V	Pass	'و -
	T	801 nS	761 - 841 ns	Pass	-
<del>(with {</del>	<del>S-Sec-Sync-Pulse c</del>	cate the result of the CPU oming from the J314 - pin code and error description	<del>(49):</del>	Pass	Fail  (20)
4.2.4.3 Scan Control 4.2.4.3/16 The input p 4.2.4.3/23 Inhibit input 4.2.4.3/35 The input p 4.2.4.3/43 Inhibit input 4.2.4.3/55 The output	oorts 0 and 1 tests at port 0 and 1 tests oorts 2 and 3 tests at port 2 and 3 tests			Pass Fail Pass Fail Pass Fail Pass Fail Pass Fail	

# TEST DATA SHEET 3 (Sheet 2 of 2) A1 Digital Processor (Paragraph 4.2.4)

4.2.4.3 Scan	Control Interface Tests (Cont):					
4.2.4.3/63 The	e output ports 2 and 3 tests  Pass Fail					
	If "Fail", record the error code and error description.					
	Error Description: None					
	Error Description: None					
4.2.4.4 Timin	ng and Control Tests:					
4.2.4.4/13	The Integrate and Hold pulse and the Dump pulse at the card rack slot J308. Pass Fail					
4.2.4.4/23	The Integrate and Hold pulse and the Dump pulse at the card rack slot J309. Pass Fail					
4.2.4.4/33	The Integrate and Hold pulse and the Dump pulse at the card rack slot J310. Pass Fail					
4.2.4.4/43	The Integrate and Hold pulse and the Dump pulse at the card rack slot J311. Pass Fail					
4.2.4.4/54	The Integrate and Hold pulse and the Dump pulse at the card rack slot J301. Pass Fail					
4.2.4.4/64	The Antenna Strobe pulse test at J320.					
4.2.4.4/68	The Antenna Strobe pulse test at J323.  Pass Fail					
4.2.4.4/78	The test of the interface to the Temp. Sensor Analog Mux card rack slot  [Pass] Fail  J306.					
4.2.4.4/89	The test of the interface to the Analog Mux and Converter card rack slot  J307.  Fail					
	If "Fail", record error code and error description:					
	Error Code: Von e					
	Error Description: None					
Assembly No.	1331670-2 Shop Order No. 292504					
Serial No	Fail Fail					
Test Engineer Dunt 3/4/98 Quality Control (Signature) (Date)						
Customer Rep	(Signature (Date)  Oresentative (Flight hardware only)  (Signature)  (Signature)  (Signature)  (Date)					

# TEST DATA SHEET 4 A1 Relay Driver Tests (Paragraph 4.2.5.2)

		Pass/Fail
23	Module power connects	Pass
26	Survival heater power turns on	Pass
27	Survival heater power turns off	Pass
28	Module power disconnects	Pass
30	Scanner 1 power turns on	Pass
31	Scanner 2 power turns on	Pass
32	Scanner 1 power turns off	Pas,
32	Scanner 2 power turns off	Pass
34	PLLO toggle	Pass
35	Module power disconnect	P263

Customer Representative (Flight hardware only)

# TEST DATA SHEET 5 Al Independence Of Measurements (Paragraph 4.2.6.1)

		CCA Serial. No. Fo	* * *		
rest Set-up verifi	ed: YES_	NO			
Supply		Measured Value (V)	<u>Lim</u>	its (V)	) <b>)</b>
+5		+4.80	+5 ±	0.25	
+15		+15.88	+15	± 1.0	
-15		-15.44	-15	± 1.0	
Integrate and Dump/Filter CCA Serial No.	Channel No.	Average for SIGNAL switch in HI position	Average for SIGNAL switch in LO position	Measurement Dependence ≤0.01%	Pass/ Fail
	0	14100.6	14099.2	0.0021%	P265
F29	1	14102.2	14100.5	0.0016%	P285
	2	14103	14101.2	0.0018%	Pass
	3	14105.3	14103,4	0.0029%	Pass
	0	14033	14030.8	0.0034%	P255
F 30	-1	14052,4	14049.9	0.0038%	P255
7 30	2	14042.8	14040.7	0.0032%	Pass
	3	14048,5	14046.1	0.0037%	P255
	0	14047.9	14046	0,0019%	Pass
E 20	1	14030.7	14029	0.0026%	Pass
F32	2	14050.8	14048,7	0.0032%	P285
	3	14050.5	14048,3	0.0034%	Pass
	0	14040.5	14038,5	0.003/70	Pass
C フ フ	1	140 48	14045.8	0,0034%	1253
F33	2	14034,1	14031.9	0,0034%	Pass
	3	14040.9	14038,8	0.003276	P265

Assembly No. 1331670-2	Shop Order No. 292504
Serial No	Pass Fail
Test Engineer D Sund 3/4/98	Quality Control 1998
(Signature (Date)	(Signature) (Date)
Customer Representative (Flight hardware only) (Signatu	re) (Date)

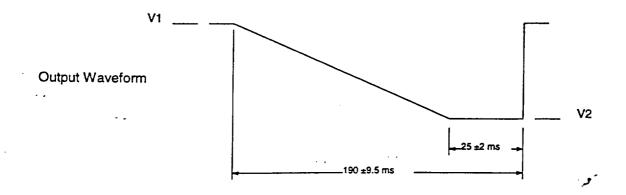
•• TEST DATA SHEET 6 (Sheet 1 Of 2)
Al Integrator Signal Multiplexing, And Digitization (Paragraph 4.2.6.2)

Analog Mux and A/D Converter CCA: Ser. No. Fo3
Integrate and Dump/Filter CCA:

Rack Slot J308: Rack Slot J309: Rack Slot J310: Ser. No. <u>F19</u> Ser. No. <u>F30</u> Ser. No. <u>F31</u>

Rack Slot J311:

Ser. No. <u>F 33</u>



Channel	· . Data	Data Limits	Data Pass/Fail	Integrator Waveform Pass/Fail
3	29143	27282 to 31076	P255	Pass
. 4	29022	27282 to 31076	1255	Pass
5	28890	27282 to 31076	Pass	Pass
6	28972	27282 to 31076	Pass	Pass
7	29/36	27282 to 31076	P255	Pass
8	29056	27282 to 31076	Pass	Pass
9	29061	27282 to 31076	Pass	P265
10	29043	27282 to 31076	Pass	Pass
11	29130	27282 to 31076	P255	Pass
12	28972	27282 to 31076	Pass	Pass
13	29039	27282 to 31076	Pass	1235
14	29018	27282 to 31076	Pass	Pass
15	29048	27282 to 31076	P2 55	Pass

# TEST DATA SHEET 6 (Sheet 2 Of 2) Al Integrator Signal Multiplexing, And Digitization (Paragraph 4.2.6.2)

Signal Name	Output	Output Return	Signal Levels	Pass/Fail
I/H	J301-42	J301-41	Pulses (TTL)	Pass
Dump	J301-45	J301-41	Pulses (TTL)	P255
+5 Vdc GSE Interlock A	J301-61	J301-70	+5 V	Pass
+5 Vdc GSE Interlock B	J301-62	J301-70	+5 V	P255

Assembly No. 1331670-2	Shop Order No. 292504
Serial No. FOI	Pass Fail
Test Engineer D Sund 3/4/	Quality Condoi
(Signature (Date)  Customer Representative (Flight hardware only)	DW. 132198
	(Signature) (Date)

# TEST DATA SHEET 7 (Sheet 1 of 2) A1 Temperature Monitoring Circuits (Paragraph 4.2.6.3)

Temperature Sensor A CCA(J303) Serial No. FO8
Temperature Sensor B CCA (J304) Serial No. F15
Temperature Sensor B CCA (J305) Serial No. F26

Temperature Sensor Analog Mux CCA (J306) Serial No. \_\_F/5\_

Dig. A Temp No.	Description	Data	Data Limits	Pass/Fai
1	Scan Motor A1-1	30893	28259 to 32513	Pass
2	<del>-   </del>	3/232	28259 to 32513	Pass
3	Scan Motor A1-2	31065	28259 to 32513	
· · · · · · · · · · · · · · · · · · ·	Feedhorn A1-1	3/437	28259 to 32513	P2755
4	Feedhorn A1-2		L	Pass
5	RF MUX A1-1	30904	28259 to 32513	Pass
6	RF MUX A1-2	30752	28259 to 32513	Pass
7	LO CH 3	30764	28259 to 32513	Pass
8	LO CH 4	30832	28259 to 32513	Pass
9	LO CH 5	3//99	28259 to 32513	Pass
10	LO CH 6	30894	28259 to 32513	P255
11	LO CH 7	3/03/	28259 to 32513	Pass
12	LO CH 8	30562	28259 to 32513	P255
13	LO CH 15	3073/	28259 to 32513	Pass
14	PLO #2	30830	28259 to 32513	P055
15	PLO #1	30899	28259 to 32513	P255
16	N/A	N/A -	-28259 to 325132 N/A	NIA
17	Mixer IF CH 3	30944	28259 to 32513	Pass
18	Mixer IF CH 4	30924	28259 to 32513	Pass
19	Mixer IF CH 5	30815	28259 to 32513	Pass
20	Mixer IF CH 6	31050	28259 to 32513	Pass
21	Mixer IF CH 7	30743	28259 to 32513	Pass
22	Mixer IF CH 8	30630	28259 to 32513	Pass
23	Mixer IF CH 9/14	30833	28259 to 32513	Pass
24	Mixer IF CH 15	30854	28259 to 32513	Pass
25	IF Amp CH 11/14	30807	28259 to 32513	Pass
26	IF Amp CH 9	3/039	28259 to 32513	Pass
27	IF Amp CH 10	30881	28259 to 32513	P255
28	IF Amp CH 11	30936	28259 to 32513	Pass
29	DC/DC Conv	30815	28259 to 32513	Pass
30	IF Amp CH 13	30944	28259 to 32513	Pass
31	IF Amp CH 14	30720	28259 to 32513	Poss
32	IF Amp CH 12	30653	28259 to 32513	Pass
33	RF Shelf A1-1	3/07/	28259 to 32513	Pass
34	RF Shelf A1-2	30672	28259 to 32513	
35			28259 to 32513	P355
33	Detector/Preamp	31084	20237 (0 32313	P355



# TEST DATA SHEET 7 (Sheet 2 of 2) A1 Temperature Monitoring Circuits (Paragraph 4.2.6.3)

Dig. A Temp No.	Description	Data	Data Limits	Pass/Fail
36	A1-1 Warm Load 1	21290	20339 to 23401	Pass
37	A1-1 Warm Load 2	21163	20339 to 23401	Pass
38	A1-1 Warm Load 3	21463	20339 to 23401	Pass
39	A1-1 Warm Load 4	22176	20339 to 23401	Pass
40	A1-1 Warm Load C	22316	20339 to 23401	Pass
41	A1-2 Warm Load 1	22594	20339 to 23401	Pass
42	A1-2 Warm Load 2	22283	20339 to 23401	Pass
43	A1-2 Warm Load 3	22381	20339 to 23401	Pass
44	A1-2 Warm Load 4	22303	20339 to 23401	P2 55
45	A1-2 Warm Load C	22173	20339 to 23401	Pass
46	Thermal Reference	25007	23340 to 26320	Pass

Assembly No. 133/670-2 Shop Order No. 292504

Serial No. Fol Pass Fail

Test Engineer Osignature (Date)

Customer Representative (Flight hardware only)

(Signature) (Date)

(Signature) (Date)

TEST DATA SHEET 8
Al Analog Telemetry (Paragraph 4.2.6.4)

ANALOG HSKP	DVM Reading	Limits (V)	Pass/Fail
Switch Position	(V)		
1	3.0/	2.85 to 3.15	Pass
2	3.47	3.30 to 3.66	Pass
3	3.00	2.87 to 3.17	Pass
4	3.03	2.85 to 3.15	Pass
5	3.47	3.30 to 3.66	P255
6	3.02	2.87 to 3.17	Pass
7	3,47	3.30 to 3.66	Pass
8	3.01	2.87 to 3.17	Pass
9	3.00	2.85 to 3.15	Pass
10	3.59	3.42 to 3.78	Pass
- 11	3.28	3.13 to 3.45	Pass
12	2.98	2.84 to 3.14	P255
13	2.97	2.84 to 3.14	P255
14	2.98	2.84 to 3.14	Pass
15	2.98	2.84 to 3.14	Pass
16	2.99	2.84 to 3.14	Pas s
17	2.98	2.84 to 3.14	Pass
18	3.47	3.30 to 3.66	1 <sup>2</sup> 435
19	4.47	4.30 to 4.66	Pass
19	0.46	0.4 to 0.48	Pass
20-	4.47	4.30 to 4.66	Pass
20	0.46	0.4 to 0.48	Pass
21	+0.002	-0.05 to 0.05	Pass
21	2.97	2.8 to 3.4	Pass
22	+0.007	-0.05 to 0.05	Pass
22	2,95	2.8 to 3.4	Pass

Assembly No. 133/670-2	Shop Order No. 292504
Serial No. FOI	Pass Fail
Test Engineer Sund 3/4/98 (Signature (Date)	Quality Control (Signature) (Date)
Customer Representative (Flight hardware only) (Signature	Aur 3-3678

# TEST DATA SHEET 9 A1 Scan Drive/ Signal Processor Tests (Paragraph 4.3.1 And 4.3.2)

A1-1 I	Orive Subsystem CC	As:	•	
T	C	(1220) See No. 1= 28		
Resolv	ce Convener CCA (	(J320) Ser. No		
R/D C	onverter/Oscillator	CCA (J322) Ser. No. <u>F/8</u>		(22)
		or (J401) Ser. No.	<i>ii</i>	(229)
Test Sa	et-up Verified:	Yes No		3/4/08
1030 30	ct-up vermeu.	103		
	Para/Step No.	Mode	Pass/Fail	
	4.3.1.2.1/12 H	Motor in warm cal position	Pass	
	4.3.1.2.2/3	Motor in nadir position	P255	
	4.3.1.2.3/2	Motor in cold cal position 1	Pass	
••	4.3.1.2.3/3	Motor in cold cal position 2	12 2 2 2 2	_
	4.3.1.2.3/4	Motor in cold cal position 3	Pass	
	4.3.1.2.3/5	Motor in cold cal position 4	PZSS	_
	4.3.1.2.4/5	Motor in full scan mode	Pass	_
	4.3.1.2.5/9	GSE mode 2	Pass	╛
	4.3.1.2.6/4	GSE mode 4	P255 ,	_
	4.3.1.2.7/4	GSE mode 5	Pass	_
	4.3.1.2.8/4	GSE mode 1	Pass	_
	4.3.1.2.9/4	GSE mode 3	Pass	_
	4.3.1.2.9/7	GSE mode 7	Pas>	_
	4.3.1.2.10/2	Scan power off	Pass	
4125		A		
A1-2 L	Prive Subsystem CC	As:		
Interfac	ce Converter CCA (	J323) Ser. No. <u>F27</u>		
Resolv	er Data Isolator CC	A (J324) Ser. No		_
R/D Co	onverter/Oscillator (	CCA (J325) Ser. No. 1-19		QO
-Motor-	<del>Driver 3-Hall Sense</del>	r (J404) Ser. No		(229)
Test Se	et-up Verified:	Yes No		3/4/18
Par	ra. No./Step No.		•	
4.3.2.2	A1-2 scan	drive operates in full scan mode. Pass Fail	<del></del>	
Assem	bly No. 133/	670-2 Shop Order No. 29	2504	
Serial 1	No. FOI	Pass Fail	<del></del>	
Test Er	ngineer Signature	(Date) Quality Control (Signature	(Date)	$\searrow$
Custon		Flight hardware only) R. Lucu 3-51	B.	
		(Signature) (Date)		

# TEST DATA SHEET 10 Al Supply Currents (Paragraph 4.4)

Voltages	Measured Current	Limits (in mA)	Pass/Fail
+28.7V	7, 7	6 to 12	Pass
+5.7V	808	700 to 1642	PJSS
+15.7V	195	152 to 364	Pass
-15.7V	190	162 to 381	Pass

Assembly No. 1331670 - 2	Shop Order No. 292504
Serial No. FØ	Pass Fail
Test Engineer 3/4/98 (Signature (Date)	Quality Control (Signature) (Pate)
Customer Representative (Flight hardware only) (Signatur	3-31-18 (Date)

TAR NO.	003142	542   FIM NO	ASSY	NAME SIGNA	L PROCESSOR
TEST ANOMAL	RECORD	DATE 12897 Page 1 of 1	ASSY	P/N /33/470	-Z REV F
_		SPEC (MPI, AE)) 26754	REV <u>~</u> ASSY	S/N <u>FOI</u>	
		CUMULATIVE TIME hrs		0. 292504	
REF. MPI 00-00	5)	ELAPSED TIME hrs	min TEST	OPER NO. 804	
First time for failur Type of test (EXP: 1	e at this point? YES NO	Test Proc Para No. where failure occ <u>ROCEDURE PROOF/NG</u> Para	urred <u>4. 2. 4.2</u> Step No. <u>10</u>	ANE)	<i>VD.1</i>
DESCRIPTION O	FANOMALY (LIST EXP jack on TRI	ECTED AND RECORDED VALUES):	NO CLOKE to 4.94 V.		
Exterior 1	OTE VOTESED TEAM LE	ADED NAME	DEFECT CODE	TECH//	DATE .
TECH	TE NOTIFIED TEAM LE	ADER NAME A. NIETO	MW		12-8-47
OPER. STATIO 3040 AMSA 3045 INSP ROUBLESHOO	Inspection to notify  Inspection to notify  I/REWORK/RETEST ACT	ction of failure/anomaly. (Except of DCMC of failure / anomaly. (GFE)  ION PLAN:			75/1971 7/4/52 
	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,			٠,٠	
	pink copy here. Delive	<del></del>	TE TEAM LEADER	RE: \$1.78/9	DATE
OPER. STAT	ION			PROD	INSP RMKS
8008 TES		CONTINUITY CHECK			
	1	DETERMINE POINT A		2CAC 1911 191	
	SIGNAL IS	S LOST AND REASON	Y FUR LOSS.	Din all	
		TEST PER AE-2475 BE DONE AFTER			
			·		
NOTE: For par PASSE Retest TECH DATE	D FAILED		PAGE Z.		
WHAT WAS TH	E CAUSE OF THE ANOM	ALY? CORRECTIVE ACTI		). a	aga OF TONG
	PAIR CLOCK L		ANE TO WIRE	` <b>P</b>	The oto "
MISSING F	EOM BACKPLAN	E SUPPLIER FOR (SHIPPER 9	INSTALLATION OF	γγ	DATE TEAM LEADER
	Deliver o	ompleted yellow copy to QA drop box; Co	mpleted original to parent	s/0 d/3	

AR NO. 002330	SYSTEM NO. ———	ASSY NAME FRAMESON ASSY
EST ANOMALY RECORD	DATE 2/3/4 \ Page 1 of	ASSY P/N 1331676 - 2 REV F
	SPEC (MPI, AE,) AE-16154 REV -	ASSY S/N Fd1
<u> </u>	CUMULATIVE TIME hrs min	S/O NO. 29 2504
REF. MPI 00-005)	ELAPSED TIME hrs min	TEST OPER NO. 120 STEP A
irst time for failure at this point? YES V NO  ype of test (EXP: T/C 1 FFT HOT)	lest Plot Pala No. Where landle occurred	<u>1,3</u> <u>5</u>
DESCRIPTION OF ANOMALY (LIST EXPECT		
Found a short between	en -15V and tlov power	swyllies lines
	A., A. /	13/13/98
2002	DESECT	CODE TECH DE DATE 2/3/41
TECH/TE NOTIFIED TEAM LEAD	DER NAME N.ETC, AL SE	2/3/91
NSTRUCTIONS:		PROD. INSP.
PER. STATION		IDI or Protect
	on of failure/anomaly. (Except engineering, N	B B Star Page 1
Sec 1 INSP Inspection to notify D	CMC of failure / anomaly. (GFE)	is a second
ROUBLESHOOT/REWORK/RETEST ACTION	NPLAN:	2 of & Brassay
	4 0-110-	. • *
Tradeshoot to detern	THE CAUSE OF PERIODS	
	TE Deca	QEV TO RE TO DATE
NOTE: Remove pink copy here. Deliver to		COOSE TOOM
ROUBLESHOOT/REWORK/RETEST/INSTRU		ZEN
PPER. STATION		PROD INSP RMKS
2010 TEST Treatestor	to backplane to determine	(145)
The property		
	ckphie Assy under mag nificalion	tor
obviou < dan	we	1469
3020 MTG Remove bar	re wire debris	MF 3
3920 M. S Nemoce Oct	- Con - Gentin	
3030 Test Repertorm	Dowerd Still non test	1007
•		1/2/98
BOXO Fet Notification	t fonatif band resumption of t	est visit
IOTE: For parts replacement continuation	on page is MANDATORY	
PASSED FAILED	GO TO S/O CONT., OR	TELOWA OF
Retest/Start   Retest/Start   Retest/Start   Retest/Start	OPERATION 120 PAGE	10 King Esono
		1777
WHAT WAS THE CAUSE OF THE ANOMAL	· I was Or will some	QE JEOUS
riece of lare wire was -		Ukk 3/2/91
cross two socket pins of		TEAM LEADER
lugging side of the T326	n (chnectal	/ TEMIVILEMUER

Deliver completed yellow copy to QA drop box; Completed original to parent 5/O

ANT MET ELECTRONIC SYSTEMS PLANT Quality Assurance

# INSPECTION INSTRUCTION

GU-TEST	DATE: 11/25/
REVISION:	DATE: C9/19
PAGE 1 OF 3	

·		<del></del> i		
S/0 NO.	OPERATION NO.	• •	·	1 676
7,67,257	PARTNAGE		PART NO.	CEG. LTZ
PROJECT NAME	1 / What is	icka Dinin	113315151	1
CHES	Date: Billing	LOT OR SEALL TO.	NEXT ASSENCE	
PREFARED:	LOTSEE	535L,	JUN 12/20 03	
V.E FELIX				·
	•			IN5
				517,

- [	CHARACTERISTIC
CENT	ERAL
A.	THIS GU-TEST SHALL BE USED AS A CHECKLIST WHEN PERFORMING TEST SET-UP, TEST MONITOR/WITNESS, AND TEST DATA REVIEW AND ACCEPTANCE.
В.	INSPECTION TIME SHALL BE CHARGED TO THE APPROPRIATE SHOP ORDER OPERATION FOR THE WORK PERFORMED PER APPLICABLE COMMAND MEDIA/PROGRAM DIRECTIVE.
c.	FOR THOSE TESTS WHERE THE AE-SPEC BECOMES A PART OF THE PLANNING PACKAGE, THE REQUIREMENTS OF CHARACTERISTIC 3, SECTION 1 SHALL APPLY.
p.	THIS GU-TEST IS DIVIDED INTO THREE SECTIONS: NOTIFICATION OF TEST/TEST MONTTOR/NYTINESS, AND DATA REVIEW. EACH SECTION SHALL BE PERFORMED FOR FACH TEST/RETEST AS REQUIRED BY THE SHOP ORDER.
E.	A SEPARATE GU-TEST SHALL BE STAMPED AND DATED BY THE INSPECTOR AS
F.	DISCREPANCIES OR REQUIRED ACTIONS SHALL BE DOCUMENTED ON AN EQCR OR TEST
G.	EACH STEP SHALL BE STANDED AND DATED BY THE INSPECTOR AS PERFORMED AND COMPLETED. NOTE: STEPS WHICH ARE NOT APPLICABLE SHALL BE ANNOTATED WITH AN "N/A" IN THE RESPECTIVE BUBBLE BY THE INSPECTOR.
Ħ.	THE COMPLETED GU-TEST SHALL BE FILED WITH THE SHOP ORDER PACKAGE.
SEC	TION 1: NOTIFICATION OF TEST
CO	APLETE HEADING OF THIS GU-TEST WITH THE APPLICABLE SHOP ORDER INFORMATION THIS APPLICABLE TEST OPERATION(S).
VE	RIFY THAT THE REQUIRED AE-SPEC IS AT THE TEST STATION AND IS THE CORRECT
EN	TER THE SHOP ORDER NUMBER, PART NUMBER, SERIAL NUMBER, AND TEST OPERATION
. RE	VIEW THE AE-SPEC AND READ AND UNDERSTAND THE QUALITY ASSURANCE PROVISIONS
	CORD SOFTWARE REV VERIFY WITH DOC CENTER AT X2377 OR GNIZANT QE THAT THIS IS THE CURRENT REV. (IF APPLICABLE)

# AEROJET ELECTRONIC SYSTEMS PLANT Quality Assurance

8.

# INSPECTION INSTRUCTION

QENO. GU-TEST	DATE: 11/25/9.
REVISION:	DATE: 09/19/9:
PAGE 2 OF 3	

	a	PAGE 2 OF 3					
\$10 NO.	OPERATION NO.						
70	1804 Jane	N57.					
	CHARACTERISTIC	5745					
CEAR. NO.							
	SECTION 1: CONTINUED	CONDUCTOR 1260					
,	SECTION 1: CONTINUED  IF ESD CERTFICATION IS SPECIFIED IN THE AE-SPEC, VER.  REQUIRED CERTIFICATION.	IFY THAT THE TEST COMBOOTON					
6.	POSSESSES THE REQUIRED OF	THAT NO STATS ARE					
7.	POSSESSES THE REQUIRED CERTIFICATION.  VERIFY THAT ALL TEST EQUIPMENT IS IN CURRENT CALIBRATION AND THAT NO SEALS ARE VERIFY THAT ALL TEST EQUIPMENT IS IN CURRENT CALIBRATION AND THAT NO SEALS ARE VERIFY THAT ALL TEST EQUIPMENT LIST (ATTACHED). FOR S/O'S WITH MULTIPLE BROKEN. COMPLETE THE TEST EQUIPMENT ON ONE FORM. IF NECESSARY, TESTS USING THE SAME SPEC, LIST ALL EQUIPMENT WHICH BEARS A "LIMITED REFERENCE THE COMPLETED FORM. NOTE: TEST EQUIPMENT WHICH BEARS A "LIMITED REFERENCE THE COMPLETED FORM. NOTE: TEST EQUIPMENT ACCEPTANCE SHALL BE CALIBRATION" STATUS SHALL BE DOCUMENTED ON AN EQCR. TEST ACCEPTANCE SHALL BE						
	CALIBRATION STATUS SIZE	$\mathcal{L} \in \mathcal{L}^{N}$					
3.	MONITOR OR VERIFY THE TEST SET-UP IN ACCORDANCE	WITH THE AESPEC AS SOLITIONS					
9.	PLANNING.  UPON COMPLETION OF STEPS 1-8, NOTIFY THE CUSTOME PLANNING REQUIREMENTS.	R OF TEST START PER SHOP ORDER					
10.	SECTION II: TEST MONITOR/WITNESS  MONITOR/WITNESS TESTING IN ACCORDANCE WITH THE DATA PRINTOUTS AND/OR DATA SHEETS TO VERIFY DATA VERIFY THAT THE AE-SPEC IS NOT REDLINED. REDLINES EQCR.	SHOP ORDER PLANNING. REVIEW A IS WITHIN THE AE-SPEC. S SHALL BE DOCUMENTED ON AN					
	SECTION III: DATA REVIEW AND ACCEPTANCE	7A 268					
12.	VERIFY THAT ALL TAR'S OR TRR'S HAVE BEEN CLOSED. REVIEW ALL DATA SHEETS AND VERIFY THAT DATA ME	ETS THE AE-SPEC REQUIREMENTS.					
13.	VERIFY THAT ALL DATA SHEETS ARE STANFED AND DATA  VERIFY THAT ALL DATA SHEETS AND SHEETS ARE STANFED AND DATA  VERIFY THAT ALL DATA SHEETS ARE STANFED AND DATA  VERIFY THAT ALL DATA SHEETS ARE STANFED AND DATA  VERIFY THAT ALL DATA SHEETS ARE STANFED AND DATA  VERIFY THAT ALL DATA SHEETS AND SHEETS AND SHEETS AND DATA SHEETS AND SHEET	TED BY TEST, INSPECTION AND THE					
14.	VERIFY THAT ALL DATA SHEETS ARE STANDED AND CUSTOMER/GOVERNMENT AS REQUIRED.  VERIFY THAT ACCEPTANCE TEST REPORTS ARE PRESEN	TED BY TEST, INSPECTION AND THE  AT AND SIGNED-OFF AND DATED.					
15.	TO CE TIEMS HAVE BEEN DISPOSITION	NED AND BOUGHT OFF BY INSPECTION.					
16.	STOP OPDER AND II OPERATIONS HA	VE BEEN STAMPED AND DATED.					
17.	VERIFY THAT ALL SHOT OLD THE	ON THE SHOP ORDER.					

STAMP AND DATE THE APPLICABLE TEST OPERATION(S) ON THE SHOP ORDER.

SONO. 294 ENT OPERATION NO.

# GU-TEST (ATTACHMENT 1) TEST EQUIPMENT LIST

	•		NO ODERTY ATD COM	
EQUIPMENT NAME	MODEL NUMBER	CAL DUE DATE	PROPERTY NUMBER or SERIAL NUMBER	
AASPTF	SK 135/293	CNR	743-5573	
	TEK TOS 380	7-13-99	200080	
O'SCOPE	SK1357273-001	· CNR	743-5719	
METSAT TRLI AMSU-A STE	N/A	, NDG	7435581	
MOTOR DRIVER TEST	SK 1293735	CNR	743-5016	
	Sk 1357408	۲/۸	743-5573	
CPLY AUXILIARY TEST		N/A	N/A	
I/O EXTENDER CARDS  I/O EXTENDER (5')  CABLE	SK 1357943	. N/A	N/A	
I/O EXT. / 1553 INTE		řΙΛ	P/A	
PERSONALITY MODILE	5K1357947/1331126	N/A	N/A :	
FOR MEMORY PERSENALITY MUDULE	Ste 1357947/1321124	NIA	r/A	
FOR SCAN CONTROL TO	CH 1357947/1331135	N/A	N/A	
ADAPTOR OCX, 4-3 hay	1 (-1 4hra41	CNR	143 - 5159	
SENSUL IK OHM ISOLATED		NIA	N/A	
SCAN DRIVE INTE.	SK 1358335	N/A	r//s	
CARLE	SK 135 \$ 395	N/A	N/A	
INTO CABLE		N/A	N/A	
upper card cage	SK1359646	NA	NA	
MEMORY CCA	(5.0)	CNR	7435683	
MOTOR / RESOLVER ASSY		1902091	143-5006 :	
ANALOG. CCA TST	5K1357280	2+34298	48007	
DVM	HP345 (A POWEY DESIGNS	7 Feb 99	143-3655	
Precision DC Source	2:10		1-509223	
Triple output	HP-63.37B	17 667.99	1-509131	
ρ.s.	50151	29 Aut. 99		

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# GU-TEST (ATTACHMENT 1) TEST EQUIPMENT LIST

•	<del></del>		
EQUIPMENT NAME	MODEL NUMBER	CAL DUE DATE	PROPERTY NUMBER or SERIAL NUMBER
P.S.	5 015 J.	20 JAN 99	41202
MultiMeter	HP-34781	4. MAR 98	52992
ATEST FIRMWARE	514 1360006	· NIA	SK136006 (RW-
	d1. vu	, N/A	N/A
(W19 - 1/25) STE. Z.W.	1 > 3 5 758 -1 Hp 332 51	11-03-98	43311
CABLE ASY.  (W19 - 1/25) STE. TST.  Synthesizer I func.  generally  Card age holder  Fix.	SK \$3 59369-1	r/A	1 /A
Fix.			
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National Aeronautics and Space Administration  Report Documentation Page						
1. Report No. 2.	Government Accession N	0.	3. Recipient's Catalog	No.		
4. Title and Subtitle			5. Report Date			
				998		
Integrated Advanced Microwave Sounding Unit-A			Performing Organiza			
(ANSO-A), METSATAT	AMSU-A), METSAT A1 Sig Processor, S/N F01			•		
7. Author(s)			Performing Organiza	ation Report No.		
			11137	·		
A. Nieto			10. Work Unit No.			
Performing Organization Name and A	Address		<b></b>			
Aerojet			11. Contract or Grant N	lo.		
1100 W. Hol	•		NAS	5-32314		
Azusa, CA 9	1702		13. Type of Report and	Period Covered		
12. Sponsoring Agency Name and Addr	ess		Final			
NASA	511.1.0		14. Sponsoring Agency Code			
Goddard Space Flight Center Greenbelt, Maryland 20771						
15. Supplementary Notes	viarylatiu 2077 i					
16. ABSTRACT (Maximum 200 words )  This is the METSAT A1 Sign F01 for the Integrated Advis	-	_	•	331670-2, S/N		
17. Key Words (Suggested by Author(s))  18.			18. Distribution Statement  Unclassified Unlimited			
Microwave System						
19. Security Classif. (of this report)	20. Security Classif. (of the	us page)	21. No. of pages	22. Price		
Unclassified	Unclassified Unclassified					
NASA FORM 1626 OCT 86			1	1		

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Integrated Advanced Microwave Sounding Unit-A (AMSU-A), METSAT A1 Sig Processor, S/N F01				NAS 5-32314		
6. AUTHOR(S) A. Nieto						
7. PERFORMING ORGANIZATION NAME(S) AND ADDRESS(ES) Aerojet				8. PERFORMING ORGANIZATION REPORT NUMBER		
1100 W. Holly					11137	_
Azusa, CA 91		145(0) AND ADDD500	<u> </u>	10	4 May 199	
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This is the METSAT A1 Signal Processor Engineering Test Report, P/N 1331670-2, S/N F01 for the Integrated Advanced Microwave Sounding Unit-A (AMSU-A).						
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Microwave System					16. PRICE CODE	
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 G
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 TA
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